Electronic Supplementary Information

High Pressure Induced Charge Transfer in 3d-4f Bimetallic Photomagnetic Materials

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Further information of structural data collection and refinement

Ambient pressure single crystal X-ray diffraction data on 1 was collected on a Bruker APEXII diffractometer with a completeness of 99.9 % to $\theta = 25.242^{\circ}$. The intensities were integrated with the program SAINT+.¹Empirical absorption correction was done in SADABS,² and structure determination was carried out with the OLEX2 program.³ 1 crystallizes in the monoclinic system with space group P2₁/n.⁴ For 2 and 3, ambient pressure data were measured on an OXFORD SuperNOVA diffractometer equipped with micro-focus Mo X-ray source and Atlas CCD detector. Data integration and reduction was performed by the CrysAlisPro system software.⁵ The completeness of both data sets was 100 % with θ up to 27.4°. Both crystals crystallized in the monoclinic system with space groups P2₁/c and P2₁/n, respectively. Further crystallographic and refinement details are given in the ESI.

High pressure X-ray Diffraction data were collected on an OXFORD SuperNOVA diffractometer. A Boehler-Almax plate DAC equipped with a pair of Type Ia Boehler Almax Design 600-µm-culet diamonds was used. Data collection, integration and reduction were performed using CrysAlisPro system software.⁵ Structure determination was carried out by using the OLEX2 program.³ The structures were refined using SHELXL and keywords DELU, SIMU, RIGU and SADI were used. However, for **1**, only the structures at 0.13(2), 0.70(5) and 1.30(3) GPa can obtained reliable structure. The completeness of those three data sets is 57.9%, 37.9% and 39%. For the others, the reliable structural refinement were obtained at 0.22(7), 1.01(6) and 2.40(4) GPa for **2** and 0.34(6) GPa for **3**.

Identification code	P0-1a	P1-1a	P2-1b	P3-1b
Pressure (GPa)	ambient	0.70(5)	0.13(2)	1.30(3)
PTM*	paratone-N	paratone-N	iso-n-pentane	iso-n-pentane
Empirical formula	C18 H36 Fe N10 O8 Y	C18 H36 Fe N10 O8 Y	C18 H36 Fe N10 O8 Y	C18 H36 Fe N10 O8 Y
Formula weight (g/mol)	665.33	665.33	665.33	665.33
Crystal system	Monoclinic	Monoclinic	Monoclinic	Monoclinic
Space group	P 2 ₁ /n	P 2 ₁ /n	P 2 ₁ /c	P 2 ₁ /c
a (Å)	17.6022(11)	17.4248(10)	13.8745(3)	13.5987(3)
<i>b</i> (Å)	8.8842(7)	8.8021(8)	8.8220(11)	8.6050(12)
<i>c</i> (Å)	19.8991(12)	19.4853(7)	24.6765(7)	23.6701(11)
β (deg.)	95.832(3)	96.288(4)	96.215(2)	94.941(3)
Volume (Å ³)	3095.7(4)	2970.6(3)	3002.7(4)	2759.5(4)
Ζ	4	4	4	4
Absorption	2.387	2.488	2.461	2.678
coefficient (mm ⁻¹)				
F(000)	1372	1372	1372	1372
Crystal size (mm ³)	0.141x0.113x0.09	0.141x0.113x0.09	0.143x0.107x0.061	0.143x0.107x0.061
Theta range for data collection (°)	1.472 to 27.482	2.103 to 26.025	1.476 to 23.252	1.503 to 23.249
Index ranges	-21<=h<=22, -	-20<=h<=18, -	-15<=h<=15, -	-15<=h<=15, -
	11<=k<=11, -25<=l<=25	7<=k<=7, -23<=l<=23	5<=k<=5, -27<=l<=27	5<=k<=5, -25<=l<=25
Reflections collected	26989	13709	16108	15666
Independent	7101	3159	2235	2115
reflections	[R(int)=0.0711]	[R(int)=0.0796]	[R(int)=0.0471]	[R(int)=0.0620]
Completeness (%)	99.9	57.9	37.9	39.0
Absorption correction		Gaussian		
Refinement method	Full-matrix least-squares on F ²			
Data / restraints / parameters	7101 / 558 / 347	3159 / 589 / 349	2235 / 318 / 357	2115 / 318 / 357
Goodness-of-fit on F^2	1.238	1.618	1.158	1.035
Final R indices	R1=0.0995,	R1=0.1532,	R1=0.0396,	R1=0.0835,
[I>2σ(I)]	wR2=0.2873	wR2=0.3647	wR2=0.0880	wR2=0.2204
R indices (all data)	R1=0.1366,	R1=0.1993,	R1=0.0556,	R1=0.1166,
	wR2=0.3296	wR2=0.4100	wR2=0.0969	wR2=0.2534
Largest diff. peak and hole $(e.Å^{-3})$	4.548 and -2.368	2.333 and -2.447	0.356 and -0.361	0.867 and -0.844

Table S1. Crystal data and structure refinement for 1

*PTM: pressure transmitting medium

	20.0	54.4		24.4	
Identification code	P0-2	P1-2	P2-2	P3-2	
Pressure (GPa)	ambient	0.22(7)	1.01(6)	2.40(4)	
PTM*	paratone-N	paratone-N	paratone-N	paratone-N	
Empirical formula	C18 H36 Co N10 O8 Y	C18 H36 Co N10 O8 Y	C18 H36 Co N10 O8 Y	C18 H36 Co N10 O8 Y	
Formula weight (g/mol)	668.41	668.41	668.41	668.41	
Crystal system	Monoclinic	Monoclinic	Monoclinic	Monoclinic	
Space group	P 2 ₁ /c	P 2 ₁ /c	P 2 ₁ /c	$P 2_1/c$	
a (Å)	13.90785(15)	13.8516(5)	13.6290(5)	13.358(2)	
<i>b</i> (Å)	8.85452(10)	8.807(2)	8.649(2)	8.473(15)	
<i>c</i> (Å)	24.7756(3)	24.6282(7)	23.9065(8)	23.152(7)	
β (deg.)	96.3669(10)	96.348(3)	95.542(3)	94.748(18)	
Volume (Å ³)	3032.23(6)	2985.9(7)	2804.8(8)	2611(5)	
Ζ	4	4	4	4	
Absorption coefficient (mm ⁻¹)	2.506	2.545	2.709	2.910	
F(000)	1376	1376	1376	1376	
Crystal size (mm ³)	0.163x0.142x0.07	0.163x0.142x0.07	0.163x0.142x0.07	0.163x0.142x0.07	
Theta range for data collection (°)	1.473 to 27.482	1.664 to 24.656	1.712 to 24.691	1.765 to 24.691	
Index ranges	-18<=h<=18, -	-16<=h<=16, -	-15<=h<=15, -4<=k<=4	, -15<=h<=15, -	
	11<=k<=11, -32<=l<=32	2 4<=k<=4, -28<=l<=27	-26<=l<=27	3<=k<=3, -27<=l<=26	
Reflections collected	36743	9636	8753	7012	
Independent	6952	2092	1943	1748	
reflections	[R(int)=0.0327]	[R(int)=0.0481]	[R(int)=0.0476]	[R(int)=0.1015]	
Completeness (%)	100.0	38.6	38.1	37.1	
Absorption correction	Gaussian				
Refinement method	Full-matrix least-squares on F ²				
Data / restraints /	6952 / 276 / 362	2092 / 237 / 165	1943 / 231 / 165	1748 / 281 / 175	
parameters $C_{\text{parameters}}$	1.050	1 412	1 117	1 557	
Goodness-oi-int on r ²	1.030 D1-0.0260	1.413 D1_0.0042	1.11/ D1_0.0822	1.33/ D1-0.1(25 D2-0.4201	
Final K indices $[I > 2\sigma(I)]$	K1=0.0309, wR2=0.0887	K1=0.0943, wR2=0.2659	K1=0.0822, wR2=0.2238	K1=0.1625, WK2=0.4501	
R indices (all data)	$R_{1=0}^{-0.0007}$	$R_{1=0} 1216$	$R_{1=0} 1077$	R1=0.2332 wR2=0.4745	
(un unu)	wR2=0.0936	wR2=0.3299	wR2=0.2697		
Largest diff. peak and hole $(e.Å^{-3})$	1.306 and -0.606	1.199 and -1.026	0.727 and -1.097	0.540 and -0.710	

 Table S2. Crystal data and structure refinement for 2

*PTM: pressure transmitting medium

Identification code	Р0-3	P1-3	
Pressure (GPa)	ambient	0.34(6)	
PTM*	paratone-N	paratone-N	
Empirical formula	C18 H36 Fe N10 Nd O8	C18 H36 Fe N10 Nd O8	
Formula weight (g/mol)	720.66	720.66	
Crystal system	Monoclinic	Monoclinic	
Space group	P 2 ₁ /n	P 2 ₁ /n	
<i>a</i> (Å)	17.63656(14)	17.4888(3)	
<i>b</i> (Å)	8.90528(7)	8.8242(6)	
<i>c</i> (Å)	19.92280(18)	19.7041(6)	
β (deg.)	95.8710(8)	96.039(2)	
Volume (Å ³)	3112.63(5)	3024.0(2)	
Ζ	4	4	
Absorption coefficient (mm ⁻¹)	2.169	2.232	
F(000)	1456	1456	
Crystal size (mm ³)	0.17x0.158x0.074	0.17x0.158x0.074	
Theta range for data collection (°)	1.469 to 27.484	1.482 to 23.246	
Index ranges	-22<=h<=22, -11<=k<=11, -25<=l<=25	-19<=h<=19, -7<=k<=7, -20<=l<=21	
Reflections collected	30365	12308	
Independent reflections	7155	2765	
Completeness (9/)	[R(int)=0.0265]	[R(int)=0.0379]	
Absorption correction	100.0	50.5	
Absorption correction	Gaussian		
Refinement method	Full-matrix least-squares on F ²		
Data / restraints / parameters	7155 / 638 / 298	2765 / 558 / 300	
Goodness-of-fit on F ²	1.049	1.092	
Final R indices $[I \ge 2\sigma(I)]$	R1=0.0401, wR2=0.1058	R1=0.0556, wR2=0.1652	
R indices (all data)	R1=0.0475, wR2=0.1122	R1=0.0687, wR2=0.1912	
Largest diff. peak and hole $(e.\text{\AA}^{-3})$	1.995 and -2.355	1.013 and -1.300	

 Table S3. Crystal data and structure refinement for 3

*PTM: pressure transmitting medium



P1 0.14 GPa



P6 4.04 GPa



P11 9.12 GPa









P7 5.12 GPa



P12 10.20 GPa P13 6.02 GPa



P3 2.06 GPa

P18 0.45 GPa



P4 2.98 GPa



P9 7.21 GPa



P14 4.84 GPa



P5 3.57 GPa



P10 8.05 GPa



P15 3.82 GPa

Figure S1. Pressure dependent crystal color of compound 1. The crystal is pressurized in a DAC with paratone-N as PTM from 0.14 GPa (P1) up to 10.22 GPa (P12), then depressurized to 2.98 GPa (P16). Then the whole DAC was put into an oven at 80°C for 10 min (P17) and cooling down to room temperature (P18). All pictures were taken at the same condition, such as same light source and exposure time.



Figure S2. Pressure dependent crystal color of compound **2**. The crystal is pressurized in a DAC with paratone-N as PTM from ambient (P0) up to 10.07 GPa (P11). The crystal becomes invisible may cause by similar refractive index between crystal and PTM.



After H, ambient

After cooling, ambient

Figure S3. Pressure dependent crystal color of compound **3**. The crystal is pressurized in a DAC with paratone-N as PTM from ambient (P0) up to 10.08 GPa (P11), then depressurized to ambient (P14). Then the whole DAC was put into an oven at 80°C for 10 min (after H) and cooling down to room temperature (after cooling). All pictures were taken at the same condition, such as same light source and exposure time.



Figure S4. Pressure dependent changes of unit cell parameters of compound 1 (a), 2 (b) and 3 (c). Filled symbols show data collected in paratone-N oil, empty symbols show data collected in iso-n-pentane.



Figure S5. X-ray absorption K-edge of Fe and Y standard compounds.



Figure S6. Experimental setup of high-pressure XANES.



Figure S7. Pressure dependent Fe/Co-C (a-c) and Y/Nd-O/N (d-f) bond distances of compound **1** (a,d), **2** (b,e), and **3** (c,f). The highest pressure of the determined structures are 1.3, 2.35 and 0.32 GPa for **1**, **2** and **3** respectively.

Reference

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